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|-----------------------------------|--|-------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/714,182 | CHRISTIAN, JOHN P. | |
| Examiner | | Art Unit | | Page 1 of 2 |
| BRIAN P. YENKE | | 2622 | | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | A | US-6,662,365 | 12-2003 | Sullivan et al. | 725/25 |
| * | B | US-6,724,351 | 04-2004 | Boger, Robert A. | 345/3.2 |
| * | C | US-6,601,181 | 07-2003 | Thomas, Keith | 713/340 |
| * | D | US-6,326,935 | 12-2001 | Boger, Robert A. | 345/3.2 |
| * | E | US-2005/0044189 | 02-2005 | Ikezoye et al. | 709/219 |
| * | F | US-2004/0073610 | 04-2004 | Terada et al. | 709/203 |
| * | G | US-2003/0014766 | 01-2003 | Dinwiddie et al. | 725/126 |
| * | H | US-2002/0069410 | 06-2002 | Atmakuri et al. | 725/37 |
| * | I | US-6,202,211 | 03-2001 | Williams, Jr., Henry R. | 725/78 |
| * | J | US-6,353,460 | 03-2002 | Sokawa et al. | 348/555 |
| * | K | US-6,630,964 | 10-2003 | Burns et al. | 348/554 |
| * | L | US-2006/0048204 | 03-2006 | Baker, Keith | 725/134 |
| * | M | US-6,188,448 | 02-2001 | Pauley et al. | 348/731 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | |
|-----------------------------------|-------------------------|---|
| Notice of References Cited | Application/Control No. | Applicant(s)/Patent Under Reexamination |
| | 10/714,182 | CHRISTIAN, JOHN P. |
| | Examiner | Art Unit |
| | BRIAN P. YENKE | 2622 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-5,982,411 | 11-1999 | Eyer et al. | 725/49 |
| * | B | US-5,559,838 | 09-1996 | Nakagoshi, Arata | 375/347 |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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NON-PATENT DOCUMENTS

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| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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| | X | |

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